

# **CE EMC TEST REPORT**

Report No.: DDT-B22111803-3E01

Applicant	:	Tiandy technologies co., ltd	
Address	:	NO.8, HAITAI HUAKE RD2 (OUTSIDE RING ROAD), HUAYUAN NEW TECHNOLOGY INDUSTRIAL PARK, TIANJIN 300384 CHINA	
Equipment under Test	:	Net Video Recorder	
Model No.	:	TC-R3432	
Series Model No.	:	TC-R3420,TC-R3440	
Trade Mark	:	Tiandy	
Manufacturer		Tiandy technologies co., ltd	
Address	:	NO.8, HAITAI HUAKE RD2 (OUTSIDE RING ROAD), HUAYUAN NEW TECHNOLOGY INDUSTRIAL PARK, TIANJIN 300384 CHINA	

Issued By: Tianjin Dongdian Testing for vice Co., Ltd.

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# **Test Report Declare**

Applicant	:	Tiandy technologies co., ltd
Address : HUAYUAN NEW TECH		NO.8, HAITAI HUAKE RD2 (OUTSIDE RING ROAD), HUAYUAN NEW TECHNOLOGY INDUSTRIAL PARK, TIANJIN 300384 CHINA
<b>Equipment Under Test</b>	:	Net Video Recorder
Model No.	(6	TC-R3432
Series Model No.	. 6	TC-R3420,TC-R3440
Trade Mark		Tiandy
Manufacturer	:	Tiandy technologies co., Itd
Address	: 1	NO.8, HAITAI HUAKE RD2 (OUTSIDE RING ROAD), HUAYUAN NEW TECHNOLOGY INDUSTRIAL PARK, TIANJIN 300384 CHINA

#### **Test Standard Used:**

EN 55032:2015/A11:2020,

EN 55035:2017/A11:2020,

EN IEC 61000-3-2:2019/A1:2021,

EN 61000-3-3:2013/A1:2019

EN 50130-4:2011/A1:2014

#### **Test Procedure Used:**

IEC 61000-4-2:2008, IEC 61000-4-3:2020, IEC 61000-4-4:2012,

IEC 61000-4-5:2014+AMD1:2017, IEC 61000-4-6:2013, IEC 61000-4-8:2009,

IEC 61000-4-11:2020

#### We Declare:

The equipment described above is tested and assessed by Tianjin Dongdian Testing Service Co., Ltd. and in the configuration assessed the equipment complied with the standards specified above. The tested and assessed results are contained in this test report and Tantin Dongstian Testing Service Co., Ltd. is assumed of full responsibility for the accuracy and completeness of these assessments.

After test and evaluation, our opinion is that the equipment in accordance with above standards.

Report No.:	DDT-B22111803-3E01			检验检测专用章 Inspection & Testing Services
Date of Receipt:	Dec. 05, 2022	Date of Test:	Dec. 07, 2022	2 ~ Boo. 27, 2022

CE

Prepared By:

Approved By:

y Gao

Haron Zhang

Report No.: DDT-B22111803-3E01

Zoey Gao/Engineer

Aaron Zhang/EMC Manager

Note: This report applies to above tested sample only. This report shall not be reproduced in parts without written approval of Tianjin Dongdian Testing Service Co., Ltd.

The report must not be used by the client to claim product certification, approval, or endorsement by NVLAP, NIST, or any agency of the U.S. Government.

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# **Revision History**

Rev.	Revisions		Issue Date	Revised By
	Initial issue	(8)	Dec. 29, 2022	(8)
	207	207		7

# 1. Summary of Test Results

	Emission				
Description of Test Iter				Result	
Conducted emission at A mains terminals	C	EN 55032:2015/A11:2020 EN 55032:2015/A11:2020			
Conducted emission at telecommunication port	EN 55032:2015/A				
Radiated emission	EN 55032:2015/A	11:2020		PASS	
Harmonic current	EN IEC 61000-3	-2:2019		N/A ®	
Voltage fluctuation & Flick	er EN 61000-3-3:2013	3/A1:2019		PASS	
	Immunity				
Description of Test Item	Standard	Result	Perform: Required	ance Criteria Observation	
Mains supply voltage variations	EN 50130-4: 2011/A1:2014	Pass	A*	A*	
Electrostatic discharge (ESD)	IEC 61000-4-2:2008 EN 55035:2017/A11:2020 EN 50130-4:2011/A1:2014	Pass	B A*	A A*	
Radiated, radio- frequency, electromagnetic field	IEC 61000-4-3:2020 EN 55035:2017/A11:2020 EN 50130-4:2011/A1:2014	Pass	A A*®	A A*	
Electrical fast transients (EFT)	IEC 61000-4-4:2012 EN 55035:2017/A11:2020 EN 50130-4:2011/A1:2014	Pass	B A*	A A*	
Surges	IEC 61000-4- 5:2014+AMD1:2017 EN 55035:2017/A11:2020 EN 50130-4:2011/A1:2014	Pass	B/C A*	A A*	
Continuous conducted disturbances	IEC 61000-4-6:2013 EN 55035:2017/A11:2020 EN 50130-4:2011/A1:2014	Pass	A A*	A A*	
Power frequency magnetic field	IEC 61000-4-8:2009 EN 55035:2017/A11:2020	Pass	A A*	A A*	
Voltage dips, < 5%		Pass	В	A ®	
Voltage dips, 70%	IEC 61000-4-11:2020 EN 55035:2017/A11:2020	Pass	С	Α	
Voltage interruptions		Pass	С	C	
Voltage dips, 80%		Pass	A*	A*	
Voltage dips, 70%	EN 50430 4:0044/44:0044	Pass	A*	A*	
Voltage dips, 40%	EN 50130-4:2011/A1:2014	Pass	A*	A*	
Voltage interruptions	7	Pass	B*	B*	
Note: N/A is an abbreviation	on for Not Applicable.				

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# 2. General Test Information

# 2.1 Description of EUT

EUT* Name	:	Net Video Recorder ®
Model Number	:	TC-R3432
Series Model No.	:	TC-R3420,TC-R3440
Model Differences	-	Models applied for this application are the equipment color, sales area and salesman, which do not affect the material, electromagnetic compatibility and safety electrical performance of the product.
Test Model	:	TC- R3432
Serial Number	ŀ	484165C2456A00001
EUT function description	:	Please refer to user manual of this device
Power supply	:	DC 12V(power supply by 100-240V,50HZ/60Hz AC/DC adapter)
EUT Class	:	Class A
Maximum work frequency		25 MHz

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Note: EUT is the abbreviation of equipment under test.

# 2.2 Primary Function of EUT

Description
N/A
N/A
N/A
Display output
N/A
Data transmission
N/A
N/A
N/A
⊚ N/A

Note: "⊠" means the product does not have this function, "⊡" means the product has this function, N/A means not applicable

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# 2.3 Port of EUT

Port	Description		
☑AC mains power port	AC Main Port(power supply by 100-240V,50HZ/60Hz AC/DC adapter)		
⊠DC network power port	N/A		
☑Wired network port	Two LAN ports		
⊠Signal data/control port	N/A		
⊠Antenna port	N/A		
⊠Broadcast receiver tuner port	N/A		
☑Audio output/input t port	One Audio out port,One MIC in port		
☑Video output port	One VGA port,One HDMI port		
☑Other:	Two USB-A ports,One eSATA port		

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# 2.4 Accessories of EUT

Description of Accessories	Manufacturer	Model number	Description	Remark
3D Optical Mouse	N/A	N/A	N/A	N/A
AC Adapter	Channel Well Technology(Gua ngzhou)Co.,Ltd	KPL-060F-VI	N/A ®	CWT

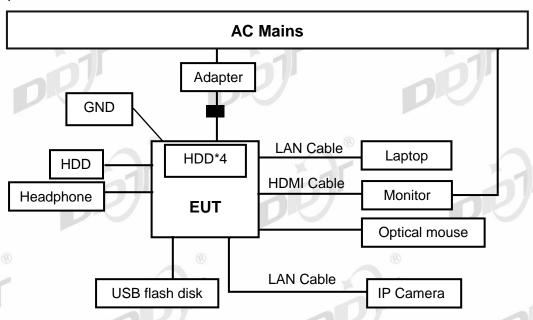
# 2.5 Test peripherals

Device	Manufacturer	Model No.	Serial No.	Remark
Laptop	HP	HP ProBook 455R G6	5CD0122F5D	HP
Laptop	Lenovo	WEI6 14 ITL	MP22HP0E	Lenovo
Monitor	SAMSUNG	LS24C350HLAG KR	ZYJ8HTEF600031F	SAMSUN G
Monitor	SAMSUNG	U32H750UMC	0QMVHTPJ200038Y	SAMSUN G
HDD	SEAGATE	ST3000VX006	W6A1SH7VV W6A1SJPG	SEAGATE
HDD	SAMSUNG	HD322HJ	S1CLJ90Z104571	SAMSUN G
HDD	SEAGATE	ST1000DM010	ZN1GC0NF ZN1GAWHW	SEAGATE
USB flash disk	KINGSTON	N/A	N/A	N/A
Headphone	SALAR	<sub>®</sub> V80	N/A	N/A
IP Camera	Tiandy	TC-C32PS	485897C2394A00009	Tiandy
LAN cable	N/A	N/A	Shielded, Length: 1.5m	N/A
LAN cable	N/A	N/A	Shielded, Length: 1.5m	N/A
LAN cable	N/A	N/A	Unshielded, Length: 1.5m	N/A
LAN cable	N/A	N/A	Unshielded, Length: 1.5m	N/A
	•			•

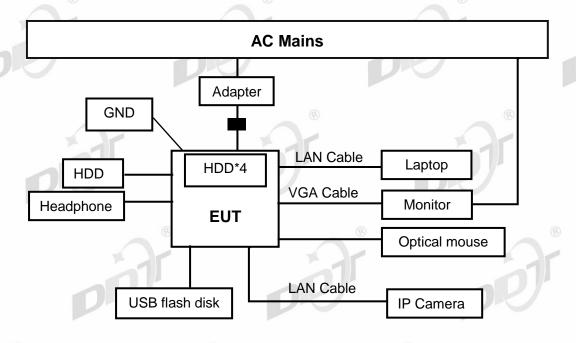
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# 2.6 Block diagram EUT configuration for test

#### Mode 1



#### Mode 2



Ferrite Core
Terminal

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# 2.7 EUT operating mode(s)

Mode1: HDMI	Connect HDMI cable from PC's HDMI port to EUT's HDMI Port.
	The monitor displays the real-time image of the camera.
Mode2: VGA	Connect VGA cable from PC's VGA port to EUT's VGA Port.
	The monitor displays the real-time image of the camera.

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Test mode description: EUT Contains four hard disks.EUT connect to laptop and IP camera with network cable. The camera's video displayed on laptop with web. Alarm in and alarm out were short connected. The laptop was at the outside of chamber when radiated emission test and continuous radio trequency disturbances test. Doing the ping test from laptop to PC.

#### 2.8 Decision of final test mode

According pre-test, the worst test modes decided as below and reported.

e-test, the worst test modes decided as below	and reported.
Conducted emission (mains power port)	Mode 1
Conducted emission(Telecommunication port)	Mode 1
Radiated emission	Mode 2
Harmonic current emissions	Mode 1
Voltage fluctuations & flicker	Mode 1
Mains supply voltage variations	Mode 1
Electrostatic discharge	Mode 1
Continuous radio frequency disturbances	Mode 1
Electrical fast transients	Mode 1
Surges	Mode 1
Continuous conducted disturbances	Mode 1
Power-frequency magnetic fields	Mode 1
Voltage dips and interruptions	Mode 1
	Conducted emission (mains power port) Conducted emission(Telecommunication port) Radiated emission Harmonic current emissions Voltage fluctuations & flicker Mains supply voltage variations Electrostatic discharge Continuous radio frequency disturbances Electrical fast transients Surges Continuous conducted disturbances Power-frequency magnetic fields

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#### 2.9 Performance Criteria

During and/or after immunity testing for EN55035:2017, the EUT was monitored to the following performance criterion.

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Criterion	Description
R	No noticeable degradation or loss of function is allowed during the test. The EUT shall continue to operate as intended without operator intervention.  The product conforms with the requirements of clause 8 of EN55035:2017.  The product conforms with the requirements of Annex of EN55035:2017.  Annex A Annex B Annex C Annex D Annex E  Annex F Annex G
® B	No noticeable degradation or loss of function is allowed after the test. The EUT shall continue to operate as intended without operator intervention. During the test, degradation of performance is allowed. No change of operating state or stored data is allowed to persist after the test.  The product conforms with the requirements of clause 8 of EN55035:2017.  The product conforms with the requirements of Annex of EN55035:2017.  Annex A Annex B Annex C Annex D Annex E
Scr ®	Loss of function is allowed, provided that the function is self recoverable. or can be restored by the operation of the controls by the user. The product conforms with the requirements of clause 8 of EN55035:2017.  The product conforms with the requirements of Annex of EN55035:2017.  Annex A Annex B Annex C Annex D Annex E  Annex F Annex G

#### 2.10 Deviations of test standard

[Standard deviation 1] Surge immunity test was done according to IEC 61000-4-5:2014+AMD1:2017 instead of IEC 61000-4-5:2005.

[Standard deviation 2] Radio-frequency conducted immunity test was done according to IEC 61000-4-6:2013 instead of IEC 61000-4-6:2008.

[Standard deviation 3] Radiated, radio-frequency, electromagnetic field immunity test was done according to IEC 61000-4-3:2020 instead of IEC 61000-4-3:2006/A1:2007/A2:2010.

[Standard deviation 4] Voltage dips, short interruptions and voltage variations immunity tests was done according to IEC 61000-4-11:2020 instead of IEC 61000-4-11:2004.

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### 2.11 Test laboratory

Tianjin Dongdian Testing Service Co., Ltd.

Address: Building D-1, No. 19, Weisi Road, Microelectronics Industrial Park Development Area, Tianjin, China.

Report No.: DDT-B22111803-3E01

Tel: +86-22-58038033, http://www.ddttest.com, Email: ddt@dgddt.com

NVLAP (National Voluntary Laboratory Accreditation Program) CODE: 500036-0

CNAS (China National Accreditation Service for Conformity Assessment) CODE: L13402

FCC Designation Number: CN5004; FCC Test Firm Registration Number: 368676

ISED (Innovation, Science and Economic Development Canada) Company Number: 27768

Conformity Assessment Body Identifier: CN0125

VCCI Facility Registration Number: C-20089, T-20093, R-20125, G-20122

### 2.12 Measurement uncertainty

Test	Item	Uncertainty		
	Main terminal	3.4dB (150KHz-30MHz)		
Conducted emission	Telecommunication (ISN T800)	4.59dB		
ar	Telecommunication (ISN ST08)	3.5dB		
Uncertainty for 10m R	adiation Emission test	5.2 dB (Antenna Polarize: H)		
(30MHz	z-1GHz)	5.2 dB (Antenna Polarize: V)		
Uncertainty for Radiation disturbance test (1GHz to 6GHz)		5.0dB		
Representation of the second of the secon	es current ®	3.1 % ®		
Voltage fluctua	ation & Flicker	1.7 %		

Note: This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=2.

We have conducted the Electrostatic discharge, Electrical fast transient/burst, Surge, Voltage dips, short interruptions and voltage variations tests to check the uncertainty. Radiated, radio-frequency, electromagnetic field 5.4dB. Conducted disturbances, induced by radio-frequency fields 1.1dB.

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# 3. Conducted Emission (mains power port)

### 3.1 General information

Test date	© Dec 7, 2022	Test engineer	Sam		
Climate condition	Ambient temperature	<b>23</b> .4±1℃	Relative humidity	37±1%	
Climate condition	Atmospheric pressure 102.1±0.2 kPa				
Test place		Shield Room 2	#		

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# 3.2 Test Equipment

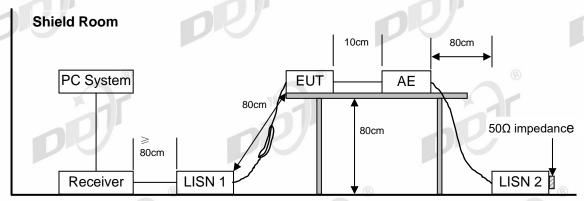
Equipment	Manufacturer	Model No.	Serial No.	ll act ('al	Cal. Interval
Test Receiver	R&S	ESCI	101397	Mar. 03, 2022	1 Year
Two-Line V-Network	R&S	ENV216	101122	Mar. 23, 2022	1 Year
Two-Line V-Network	R&S	ENV216	101254	Mar 03, 2022	1 Year
Test software	TOYO	EP5/CE	V 5.4.40	N/A	N/A

#### 3.3 Reference standard

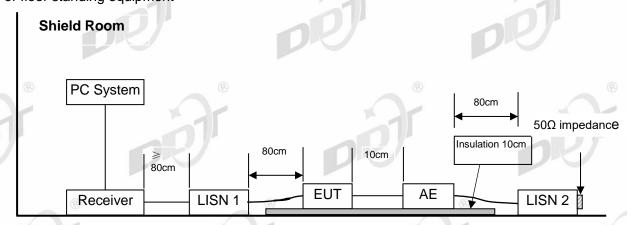
EN 55032:2015/A11:2020 (Class A)

### 3.4 Block diagram of test setup

For table-top equipment

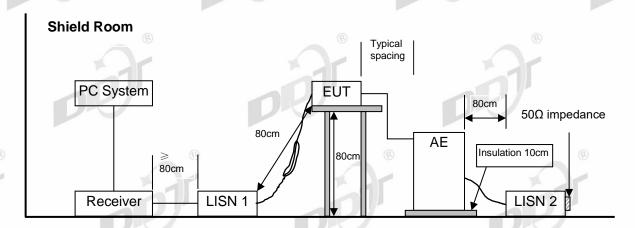


For floor standing equipment



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#### For combinations equipment



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#### 3.5 Limits

#### Class A

Frequency			Quasi-Peak Level dB(μV)	Average Level dB(μV)
150kHz	~	500kHz	79	66
500kHz	~	30MHz	73	60

#### Class B

Frequency			Quasi-Peak Level dB(μV)	Average Level dB(μV)
150kHz	~	500kHz	66 ~ 56*	56 ~ 46*
500kHz	~	5MHz	56	46
5MHz	~	30MHz	60	50

Notes: 1. \* Decreasing linearly with logarithm of frequency.

2. The lower limit shall apply at the transition frequencies.

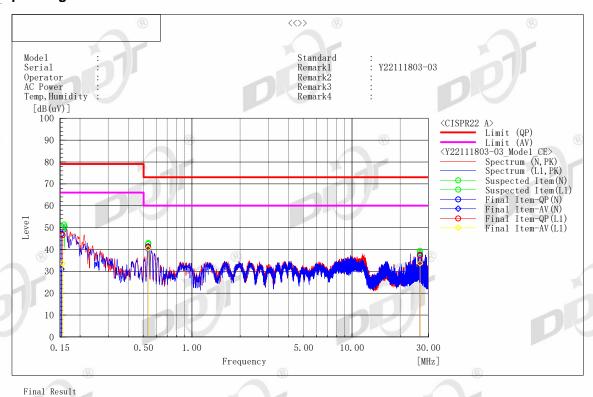
#### 3.6 Test procedure

- (1) The EUT was placed on a non-metallic table, 80cm above the ground plane.
- (2) The EUT's power adapter was connected to the power mains through a line impedance stabilization network (L.I.S.N). which this provided a 50-ohm coupling impedance for the EUT (Please refer to the block diagram of the test setup and photographs). Both sides of power line were checked for maximum conducted disturbance. In order to find the maximum emission, the relative positions of equipment and all of the interface cables were changed according to EN 55032 on conducted disturbance emission test.
- (3) The bandwidth of test receiver is set at 9 kHz.
- (4) The frequency range from 150 kHz to 30MHz is checked.
- (5) Pre-scan measurements were performed in all operating mode or resolution. But final measurements were performed in worst cases based on pre-scan measurements.

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#### 3.7 Test result

#### PASS. (See below detailed test result) **Operating Mode 1:**



	N Phase									_1	
No.	Frequency	Reading	Reading	c.f	Result	Result	Limit	Limit	Margin	Margin	Remark
		QP	CAV		QP	CAV	QP	AV	QP	CAV	
	[MHz]	[dB (uV)]	[dB(uV)]	[dB]	[dB(uV)]	[dB(uV)]	[dB(uV)]	[dB(uV)]	[dB]	[dB]	
1	0.15288	37.4	21. 2	9.8	47.2	31.0	79.0	66.0	31.8	35.0	
2	0.53312	31.5	30. 3	9.8	41.3	40. 1	73.0	60.0	31. 7	19.9	
3	26.60965	27.4	23.9	10.0	37.4	33. 9	73.0	60.0	35. 6	26. 1	
	L1 Phase	-									
No.	Frequency	Reading	Reading	c.f	Result	Result	Limit	Limit	Margin	Margin	Remark
		QP	CAV		QP	CAV	QP	AV	QP	CAV	
	[MHz]	[dB(uV)]	[dB(uV)]	[dB]	[dB(uV)]	[dB(uV)]	[dB(uV)]	[dB(uV)]	[dB]	[dB]	
1	0.15572	36. 7	23. 7	9.8	46. 5	33. 5	79.0	66.0	32. 5	32. 5	
2	0.53241	31.2	30.6	9.8	41.0	40.4	73.0	60.0	32.0	19.6	
3	26.60828	27.1	23.6	10.0	37. 1	33.6	73.0	60.0	35.9	26. 4	

Note1) Level (Quasi-Peak and/or C/Average) = Meter Reading + Factor

Note2) Line = Polarity of input power (Live or Neutral)

N: Abbreviation of Neutral Polarity, L1: Abbreviation of Live Polarity,

Note3) Factor = LISN Insertion Loss + Cable Loss

Note4) Margin = Limit – Level (Quasi-Peak and/or C/Average)

Note5) C/Average : Abbreviation of CISPR Average

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# 3.8 Test Photo



Front



Rear

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# 4. Conducted Emission (Telecommunication Port)

# 4.1 General information

Test date	© Dec 7, 2022	Test engineer	Sam		
Climate condition	Ambient temperature	<b>23</b> .4±1℃	Relative humidity	37±1%	
Climate condition	Atmospheric pressure	20%			
Test place		Shield Room 2	#		

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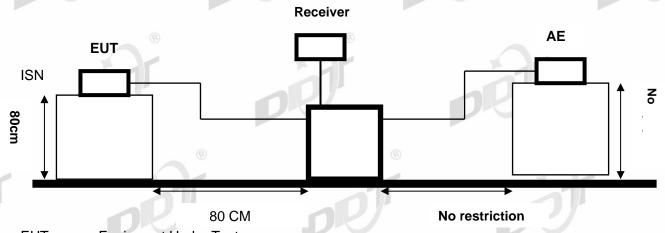
# 4.2 Test equipment

Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
Test Receiver	R&S	ESCI	101397	Mar. 03, 2022	1 Year
Two-Line V-Network	R&S	ENV216	101122	Mar. 23, 2022	1 Year
Two-Line V-Network	R&S	ENV216	101254	Mar 03, 2022	1 Year
ISN	TESEQ	T800	30844	Nov. 17, 2022	1 Year
ISN	TESEQ	ISN ST08	33992	Feb. 16, 2022	1 Year
Test software	TOYO	EP5/CE	V 5.4.40	N/A	N/A

#### 4.3 Reference standard

EN 55032:2015/A11:2020 (Class A)

# 4.4 Block diagram of test setup



EUT means Equipment Under Test AE means Associated Equipment.

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#### 4.5 Limits

#### Class A

Frequency		Quasi-Peak Level dB(μV)	Average Level dB(μV)	
150kHz	~ 500kHz	97 ~ 87*	84 ~ 74*	
5MHz	~ 30MHz	87	74	

Report No.: DDT-B22111803-3E01

#### Class B

Frequency			Quasi-Peak Le dB(μV)	Average Level dB(μV)	
150kHz	~	500kHz	84 ~ 74*	74 ~ 64*	
5MHz	~	30MHz	74	64	

Notes: 1. \* Decreasing linearly with logarithm of frequency. 2. The lower limit shall apply at the transition frequencies.

### 4.6 Test procedure

The EUT was placed on a 0.8m high non-metallic table in shielded room.

Connect ISN directly to reference ground plane.

The measured voltage at the measurement port of the ISN should correct the reading by adding the voltage division factor of the ISN, and compare to the voltage limit.

For Local Area Network (LAN) device, in order to make reliable emission measurements representative of high LAN utilization it is only necessary to create a condition of LAN utilization in excess of 10 % and sustain that level for a minimum of 250 ms. The content of the test traffic should consist of both periodic and pseudo-random messages in order to emulate realistic types of data transmission (e.g. random: files compressed or encrypted; periodic: uncompressed graphic files, memory dumps, screen updates, disk images). If the LAN maintains transmission during idle periods measurements shall also be made during idle periods.

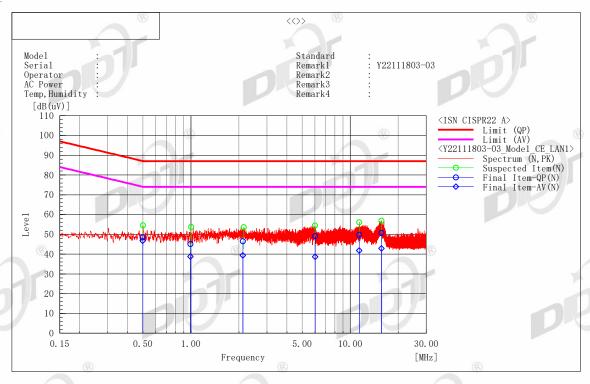
When disturbance voltage measurements are performed on a single unscreened balanced pair, an adequate ISN for two wires shall be used; when performed on unscreened cables containing two balanced pairs, an adequate ISN for four wires shall be used.

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### 4.7 Test result

# **Operating Mode 1:**

LAN1:



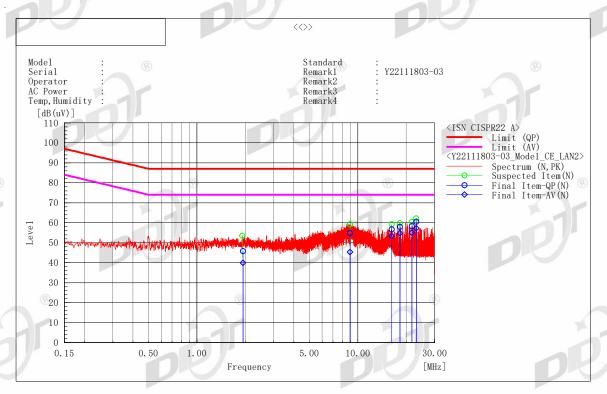
Final	Result

	N Phase										
No.	Frequency	Reading	Reading	c.f	Result	Result	Limit	Limit	Margin	Margin	Remark
		QP	CAV		QP	CAV	QP	AV	QP	CAV	
	[MHz]	[dB(uV)]	[dB(uV)]	[dB]	[dB(uV)]	[dB(uV)]	[dB(uV)]	[dB(uV)]	[dB]	[dB]	
1	15.68867	40.9	33.0	9.8	50. 7	42.8	87.0	74.0	36. 3	31.2	
2	11. 38553	40.0	32.0	9. 7	49.7	41.7	87.0	74.0	37. 3	32. 3	
3	6.02391	39. 4	29.0	9.6	49.0	38.6	87.0	74.0	38.0	35. 4	
4	0.99329	35. 5	29. 2	9.6	45. 1	38.8	87.0	74.0	41.9	35. 2	
5	0.49826	38. 7	37.0	9.7	48. 4	46.7	87.0	74.0	38.6	27. 3	
6	2.11948	36. 8	29.6	9. 7	46. 5	39.3	87.0	74.0	40.5	34. 7	

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#### LAN2:



Final Result

	N Phase										
No.	Frequency	Reading	Reading	c.f	Result	Result	Limit	Limit	Margin	Margin R	emark
		QP	CAV		QP	CAV	QP	AV	QP	CAV	
	[MHz]	[dB(uV)]	[dB(uV)]	[dB]	[dB(uV)]	[dB(uV)]	[dB(uV)]	[dB(uV)]	[dB]	[dB]	
1	23.12878	50.5	47.3	9.9	60.4	57. 2	87.0	74.0	26.6	16.8	
2	21.6622	48. 4	45. 1	9.9	58. 3	55. 0	87.0	74.0	28. 7	19.0	
3	18. 24303	48. 1	44. 9	9.9	58. 0	54. 8	87.0	74.0	29.0	19. 2	
4	8. 93954	45.0	35.6	9.7	54. 7	45. 3	87.0	74.0	32. 3	28. 7	
5	16. 22962	46.9	43.4	9.8	56. 7	53. 2	87.0	74.0	30.3	20.8	
6	1. 93494	36.0	30. 1	9.7	45. 7	39.8	87.0	74.0	41.3	34. 2	

Note1) Level (Quasi-Peak and/or C/Average) = Meter Reading + Factor

Note2) Line = Polarity of input power (Live or Neutral)

N : Abbreviation of Neutral Polarity, L1 : Abbreviation of Live Polarity,

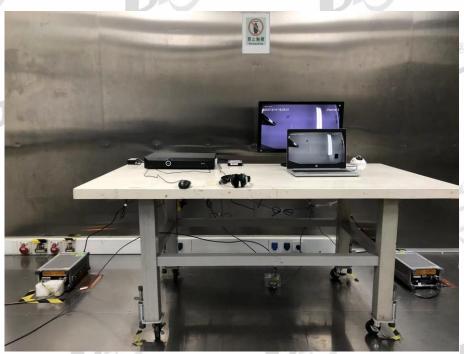
Note3) Factor = LISN Insertion Loss + Cable Loss

Note4) Margin = Limit – Level (Quasi-Peak and/or C/Average)

Note5) C/Average : Abbreviation of CISPR Average

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# 4.8 Test Photo



Front



Rear

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# 5. Radiated Emissions (30MHz to 1GHz)

### 5.1 General information

Test date	© Dec. 8, 2022	Test engineer	Jason		
Climata canditian	Ambient temperature	<b>20.2±1</b> ℃	Relative humidity 21±1		
Climate condition	Atmospheric pressure	102.6±0.2kPa	20/		
Test place		10m Chambe			

Report No.: DDT-B22111803-3E01

# 5.2 Test equipment

Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
EMI Test Receiver	R&S	ESCI	101024	Mar. 03, 2022	1 Year
<b>EMI Test Receiver</b>	R&S	ESCI	101030	Mar. 29, 2022	1 Year
Bilog Antenna	TESEQ	CBL6112D	29068	Oct, 10, 2022	2 Year
Bilog Antenna	TESEQ	CBL6112D	29069	Oct, 10, 2022	2 Year
Amplifier	Sonoma	310N	300913	Feb. 15, 2022	1 Year
Amplifier	Sonoma	310N	300914	Feb. 15, 2022	1 Year
Mast Controller	Innco	CO2000	ZOAA97AZ10 0013D	N/A	N/A
RF Selector 4CH	TOYO	NS4904N	Selector1	N/A	N/A
RF Selector 4CH	TOYO	NS4904N	Selector2	N/A	N/A
Test software	TOYO	EP5/RE	V 5.7.10	N/A <sup>®</sup>	N/A
Notes. N/A means No	ot applicable. 🧹		¥		

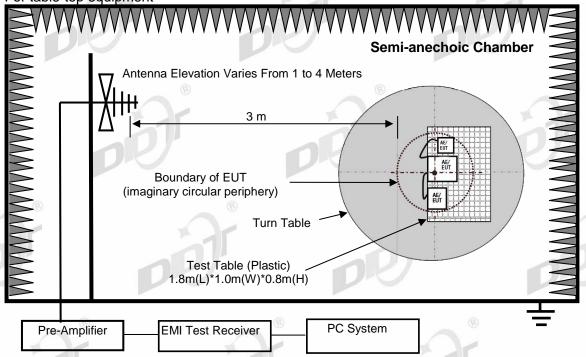
#### 5.3 Reference standard

EN 55032:2015/A11:2020 (Class A)

### 5.4 Block diagram of test setup

Below 1GHz

For table-top equipment



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#### 5.5 Limits

#### Class A

Equipment	Frequency	10m measuring distance	Field Strengths Limits at 3m measuring distance dB(μV)/m
Class A	30MHz to 230MHz	40	50
Equipment	230MHz to 1000MHz	47	57

Report No.: DDT-B22111803-3E01

#### Class B

Equipment	Frequency	10m measuring distance	Field Strengths Limits at 3m measuring distance dB(µV)/m
Class B	30MHz to 230MHz	30	40
Equipment	230MHz to 1000MHz	37	47

Note: (1) The smaller limit shall apply at the cross point between two frequency bands. (2) Distance is the distance in meters between the measuring instrument, antenna and the closest point of any part of the device or system.

### 5.6 Test procedure

#### For Radiated emissions:

- (1) The EUT was placed on a non-metallic table, 80 cm above the ground plane inside a semianechoic chamber.
- (2) Test antenna was located ∑3m / ☐10m (see note) from the EUT on an adjustable mast. A pre-scan was first performed in order to find prominent radiated emissions. For final emissions measurements at each frequency of interest, the EUT were rotated and the antenna height was varied between 1m and 4m in order to maximize the emission. Measurements in both horizontal and vertical polarities were made and the data was recorded. In order to find the maximum emission, the relative positions of equipment and all of the interface cables were changed according to EN 55032 on radiated emission test.
- (3) Spectrum frequency from 30MHz to ∑1GHz / 2GHz was investigated.
- (4) For final emissions measurements at each frequency of interest, the EUT were rotated and the antenna height was varied between 1m and 4m in order to maximize the emission. Measurements in both horizontal and vertical polarities were made and the data was recorded. In order to find the maximum emission, the relative positions of equipment and all of the interface cables were changed according to EN 55032 on Radiated Emission test.
- (5) For emissions from 30MHz to 1GHz, Quasi-Peak values were measured with EMI Receiver and the bandwidth of Receiver is 120 kHz.
- (6) Final measurements consisted of 3 steps.
  - First step, frequency fine tuning to find exact emission frequency.
  - Second step, rechecking to search for maximum height and azimuth for interference from EUT In final step, there are conducted measuring with quasi-peak detector for points which are detected from 1st step & 2nd step.
  - Results checked manually and points close to the limit line were re-measured.
- (7) Pre-scan measurements were performed in all operating mode or resolution. But final measurements were performed in worst cases based on pre-scan measurements.

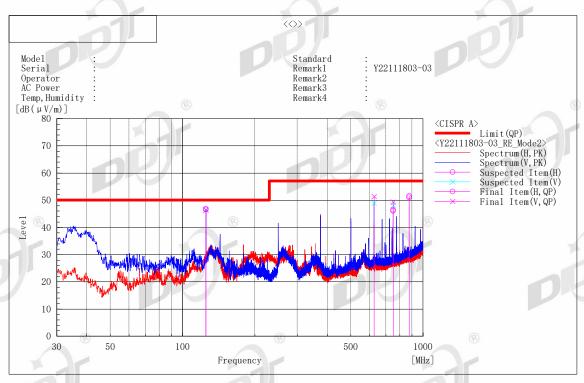
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#### 5.7 Test result

#### PASS. (See below detailed test result)

Note: All emissions not reported below are too low against the prescribed limits.

#### **Operating Mode 2:**



Report No.: DDT-B22111803-3E01

Final Result

No.	Frequency	(P)	Reading	c. f	Result	Limit	Margin	Height	Angle	System	Remark
	Crear 7		QP	5 m /4 / ) 7	QP	QP	QP	r 7	[° ]		
	[MHz]		[dB(µV)]	[dB(1/m)]	[dB(µV/m)]	[dB(µV/m)]	[dB]	[cm]	[,]		
1	125.007	Н	57.4	-10.6	46.8	50.0	3. 2	224.0	336. 1	1	
2	750.002	Н	44.7	1.8	46. 5	57.0	10.5	105.0	208.0	1	
3	875.043	Н	48.0	3.6	51.6	57.0	5.4	124.0	221.6	1	
4	125.006	V	56. 4	-9.9	46. 5	50.0	3. 5	102.0	114.4	2	
5	625. 003	V	49.4	2.0	51.4	57.0	5. 6	110.0	61.9	2	
6	749. 999	V	46. 2	3. 2	49.4	57.0	7.6	100.0	17.5	2	

Note) Receiving antenna polarization: Horizontal and/or Vertical

Test Distance: 3 m, Antenna Height: 1 m to 4 m

Level QP (Quasi-Peak) = Reading QP + Factor (Antenna Factor + Cable Loss - Amp. Gain)

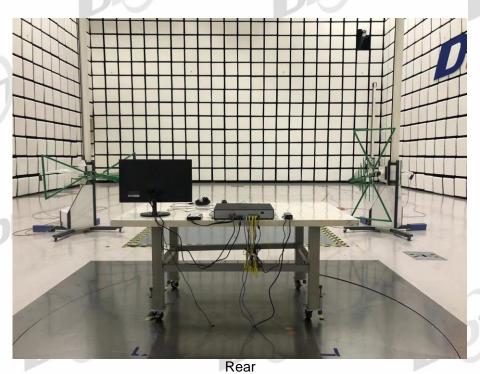
Margin QP (Quasi-Peak) = Limit - Level QP

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# 5.8 Test Photo



Front



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# 6. Radiated Emissions (Above 1GHz)

### 6.1 General information

Test date	® N/A	Test engineer	N/A®		
Climate condition	Ambient temperature	N/A	Relative humidity N/A		
Climate condition	Atmospheric pressure	20/			
Test place		10m Chambe	r		

Report No.: DDT-B22111803-3E01

# 6.2 Test equipment

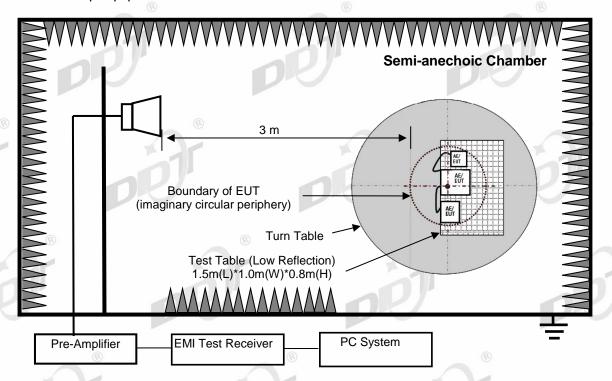
Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval			
EMI Test Receiver	R&S	ESU26	100244	Mar. 03, 2022	1 Year			
Double Ridged Horn Antenna	TESEQ	BHA9118	31754	Oct. 12, 2021	2 Year			
Pre-amplifier	TOYO	TPA0108-40	1409	Feb. 15, 2022	1 Year			
Test software	TOYO	EP5/RE	V 5.7.10	N/A	N/A			
Notes. N/A means Not applicable.								

### 6.3 Reference standard

EN 55032:2015/A11:2020 (Class A)

### 6.4 Block diagram of test setup

Above 1GHz For table-top equipment



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#### 6.5 Limits

Frequency range	Limits of Class A, dB(µV/m)		Limits of Class B, dB(µV/m)	
Limits (GHz)	Peak	C/Average	Peak	C/Average
1~3	76	56	70	50
3~6	80	60	74	54
Note: The lower limit	shall apply at th	e transition frequ	uency	

Report No.: DDT-B22111803-3E01

### 6.6 Test procedure

The highest internal source of an EUT is defined as the highest frequency generated or used within the EUT or on which the EUT operates or tunes.

If the highest frequency of the internal sources of the EUT is less than 108 MHz, the measurement shall only be made up to 1 GHz.

If the highest frequency of the internal sources of the EUT is between 108 MHz and 500 MHz, the measurement shall only be made up to 2 GHz.

If the highest frequency of the internal sources of the EUT is between 500 MHz and 1 GHz, the measurement shall only be made up to 5 GHz.

If the highest frequency of the internal sources of the EUT is above 1 GHz, the measurement shall be made up to 5 times the highest frequency or 6 GHz, whichever is less.

For emissions above 1GHz, both Peak and Average level were measured with Spectrum Analyzer, and the RBW is set at 1MHz.

Measurements within 20 dB of the limit were then maximized by adjusting turntable position.

Final measurements were made using an C/Average detector.

Results checked manually and points close to the limit line were re-measured.

Pre-scan measurements were performed in all operating mode or resolution. But final measurements were performed in worst cases based on pre-scan measurements.

#### 6.7 Test result

Not applicable: This product's highest frequency of the internal sources is less than 108 MHz, the measurement only be made up to 1 GHz.

### 6.8 Test Photo

N/A

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# 7. Harmonics current

# 7.1 General information

Test date	© Dec. 7, 2022	Test engineer	Sam			
Climate condition	Ambient temperature	<b>23</b> .4±1℃	Relative humidity	37±1%		
Climate condition	Atmospheric pressure 102.1±0.2kPa					
Test place	Shield Room 1#					

Report No.: DDT-B22111803-3E01

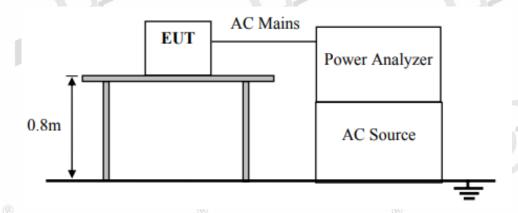
# 7.2 Test equipment

Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
Power Analyzer	N4L	PPA5511	162-04584	Dec. 27, 2021	1 year
Reference Impedance Network	Voltech	IEC61000-3	1G164/2021	Dec. 27, 2021	1 year
AC Power Source	Pacific ®	360-AMX	1235	Feb. 16, 2022	1 year

### 7.3 Reference standard

EN IEC 61000-3-2:2019/A1:2021 (Class A)

# 7.4 Block diagram of test setup



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# 7.5 Limits

Limits for Class A equipment

nits for Class A equipme	IL =				
Harmonic order		Maximum p	ermissible harmonic	current	
n		A			
Odd harmonics			7		
3		2.30		21	
5		1.14			
7		0.77			
9		0.40			
11		0.33			
13		0.21			
15 ≤ n ≤ 39		0.15 15/n			
(odd harmonics only)			4		
Even harmonics			1/2		
2		1.08			
4		0.43			
6®		0.30			
8 ≤ n ≤ 40		0.23 8/n			

Report No.: DDT-B22111803-3E01

Limits for Class D equipment

Harmonic order n	Maximum permissible harmonic current per watt mA/W	Maximum permissible harmonic current A
3 5 7 9 11 13 ≤ n ≤ 39 (odd harmonics only)	3.4 1.9 1.0 0.5 0.35 3.85/n	2.30 1.14 0.77 0.40 0.33 See Table 1

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# 7.6 Test result

# **Operating Mode 1:**

07th December 2022 - 16:	52:30	Page	IEC Soft V2. 4e
	IEC61000-3-2		
NAL	Fluctuating Ha		NIAL
N4L			N4L
Instrument Model	Instrument Deta	PPA5511	
Instrument Serial	R	162-04584	(R)
Instrument Firmware		2. 17	
Instrument Last Calibra	11	NOV 2015 1105 CI	H
Instrument Version	······································	Low Current	<del>``</del>
Instrument version	Test Setting		
Class		Class A	
Mode		Measure	
	Equipment Under	Test	
Brand		N/A	
Model		Y22111803-03	<u> </u>
Serial		N/A	
Impedance Network ID		N/A	
	Test Conditio	ns	
	User Entered		Measured
Rated Voltage	230.000 V		231.053 V
Rated Current	N/A		241.877 mA
Rated Frequency	50.000 Hz		50.000 Hz
Rated Power	N/A		18.153 W
	Additional Test Inf		
Measured Power Factor		0. 3248	<i></i>
Max Current THD		271. 54%	
Max THC		0. 2283A	
Max Power		18.337 W	(8)
Max F. Current		84.345 mA	
Average F. Current		83.516 mA	
Minimum Current Test Duration		300mA 2.5 minutes	
rest Duration	Additional Test D		
Operator	Additional lest b	N/A	
Lab Name		N/A	
Location		N/A	
Notes			
Notes	*	ar	Par
Signature	nP	<del>,                                    </del>	nP/
Results	Test - N/A.	Rated Po	wer < 75W

Report No.: DDT-B22111803-3E01

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# 7.7 Test Photo



# 8. Voltage fluctuation & Flicker

# 8.1 General information

Test date	® Dec. 7, 2022	Test engineer San			
Climate condition	Ambient temperature	<b>23</b> .4±1℃	Relative humidity	37±1%	
Climate condition	Atmospheric pressure 102.1±0.2kPa				
Test place		Shield Room 1	#		

Report No.: DDT-B22111803-3E01

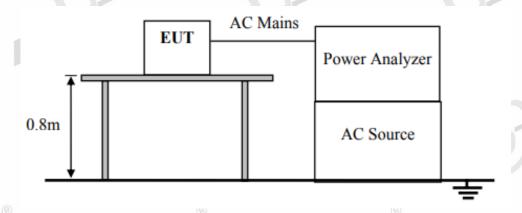
# 8.2 Test equipment

Equipment	Manufacturer	Model No.	Serial No.	II aet Cal	Cal. Interval
Power Analyzer	N4L	PPA5511	162-04584	Dec. 27, 2021	1 year
Reference Impedance Network	Voltech	IEC61000-3	1G164/2021	Dec. 27, 2021	1 year
AC Power Source	Pacific ®	360-AMX	1235	Feb. 16, 2022	1 year

### 8.3 Reference standard

EN 61000-3-3:2013/A1:2019

# 8.4 Block diagram of test setup



# 8.5 Limits

short-term flicker indicator, Pst	the relative steady- state voltage change, dc	the value of d(t) during a voltage change, d(t) >3.3 %	the maximum relative voltage change, dmax
1.0	3.3 %	500 ms	4 %

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# 8.6 Test result

# PASS. (See below detailed test result)

# Operating Mode 1:

162- 2.	5511 04584
Flickermeter Instrument Details PPA 162- 2.	5511 04584
Flickermeter Instrument Details PPA 162- 2.	5511 04584
Instrument Details PPA 162- 2.	5511 <sup>®</sup> 04584
PPA 162- 2.	04584
162- 2.	04584
$\sim 2.$	
	17
11 NOV 20	
	15 1105 CH
	urrent
	tage
	1 A
	PSTs
	/A
	7/A
	A/A
	Measured
	231. 036 V
	N/A 50.000 Hz
	N/A
	7/A
	/ A
	(-)
ne/	nk/
© Phase1	: PASS
	Norma   10.00

Report No.: DDT-B22111803-3E01

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# 8.7 Test Photo



# 9. Mains supply voltage variations

#### 9.1 General information

Test date	© Dec. 26, 2022	Test engineer	Zoey		
Climate condition	Ambient temperature	20.0±1℃	Relative humidity	37±1%	
Climate condition	Atmospheric pressure 103.0±0.2kPa				
Test place		Shield Room 3	3#		

Report No.: DDT-B22111803-3E01

### 9.2 Test equipment

Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
Programmable power supply	CHROMA	6560	656038000994	Feb. 14,2022	1 year
Paperless recorder	Yokogawa	GP20	S5R505525	Feb, 16,2022	1 year

#### 9.3 Reference standard

EN 50130-4:2011/A1:2014

#### 9.4 Block diagram of test setup

N/A

### 9.5 Test levels and performance criterion

Subject the specimen to each of the power supply conditions, indicated in Table as follow, until temperature stability is reached.

Supply voltage max(Umax)	Unom+10%	Performance Criteria
Supply voltage max(Umin)	Unom-15%	A*

Unom = Nominal mains voltage. Where provision is made to adapt the equipment to suit a number of nominal supply voltages (e.g. by transformer tap changing), the above conditioning severity shall be applied for each nominal voltage, with the equipment suitably adapted. For equipment which is claimed to be suitable for a range of nominal mains voltages (e.g. 220/240 V) without adaptation, Umax = (Maximum Unom) + 10 %, and Umin = (Minimum Unom) – 15 %. In any case the range of Unom shall include the European nominal mains voltage of 230 V.

Performance criteria A\* description:There shall be no damage, malfunction or change of status due to the different supply voltage conditions.

#### 9.6 Test procedure

Connect the specimen to suitable power supply, monitoring and loading equipment (see 5.1). The specimen shall be in its operating condition (see 5.3).

Monitor the specimen during the conditioning to detect any change in status. When temperature stability has been obtained, at each of the supply conditions, subject the specimen to the functional test (see Clause 6).

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Supply voltage:100V-240V 50Hz/60Hz AC					
Test condition		Required	Observation	Result (Pass/Fail)	
Supply voltage max(Umax)	264V	A*	A*	Pass	
Supply voltage max(Umin)	85V	A*	A*	Pass	

Report No.: DDT-B22111803-3E01

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Observation Description:

Before the conditioning, the sample function test is normal. Data transmission loss rate: 0%

A\*: No damage, malfunction or change of status due to the different supply voltage conditions.

Data transmission loss rate≤5%.

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# 10. Electrostatic Discharge

### 10.1 General information

Test date	© Dec. 14, 2022 Dec. 27,2022	Test engineer	Oliver		
Climate condition	Ambient temperature	19.5±1℃	Relative humidity	37±1%	
Climate Condition	Atmospheric pressure	102.9±0.2kPa			
Test place	Shield Room 3#				

Report No.: DDT-B22111803-3E01

## 10.2 Test equipment

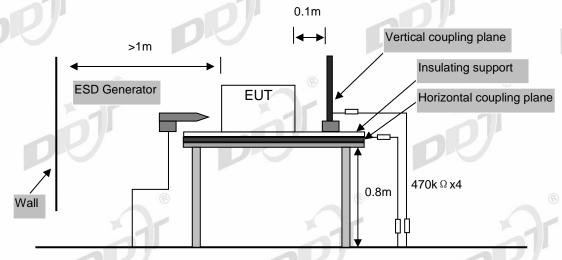
Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
ESD Generator	TESEQ	NSG 438	1040	Oct. 14, 2022	1 Year

### 10.3 Test and reference standards

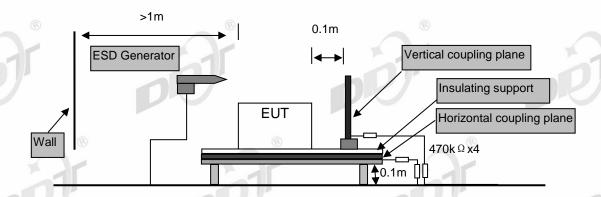
EN 55035:2017/A11:2020 IEC 61000-4-2:2008 EN 50130-4:2011/A1:2014

## 10.4 Block diagram of test setup

Table-top equipment



Floor-standing equipment



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## 10.5 Test levels and performance criterion

#### EN 55035:2017/A11:2020

Te	Performance Criteria	
Air Discharge	$\pm 2$ kV, $\pm 4$ kV and $\pm 8$ kV	P @
Contact Discharge	±4kV	В (6)

Report No.: DDT-B22111803-3E01

Performance criteria B description: During the test, degradation of performance is allowed. However, no change of operating state or stored data is allowed to persist after the test. After the test, the EUT shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed, after the application of the phenomena below a performance level specified by the manufacturer, when the EUT is used as intended.

#### EN 50130-4:2011/A1:2014

Te	Performance Criteria	
Air Discharge	±2kV, ±4kV and ±8kV	A*
Contact Discharge	±6kV	

Performance criteria A\* description: There shall be no damage, malfunction or change of status due to the conditioning. Flickering of an indicator during the application of the discharges is permissible, providing that there is no residual change in the EUT or any change in outputs, which could be interpreted by associated equipment as a change.

### 10.6 Test procedure

#### Air Discharge:

The test was applied on non-conductive surfaces of EUT. The round discharge tip of the discharge electrode was approached as fast as possible to touch the EUT. After each discharge, the discharge electrode was removed from the EUT. The generator was re-triggered for a new single discharge and repeated 20 times or 10 times for each pre-selected test point. This procedure was repeated until all the air discharge completed.

### Contact Discharge:

All the procedure was same as air discharge. Except that the generator was re-triggered for a new single discharge. The tip of the discharge electrode was touching the EUT before the discharge switch was operated.

#### Indirect discharge for horizontal coupling plane:

At least 20 or 10single discharges were applied to the horizontal coupling plane, at points on each side of the EUT. The discharge electrode positions vertically at a distance of 0.1m from the EUT and with the discharge electrode touching the coupling plane.

#### Indirect discharge for vertical coupling plane:

At least 20 or 10 single discharges were applied to the center of one vertical edge of the coupling plane. The coupling plane, of dimensions 0.5m X 0.5m, was placed parallel to, and positioned at a distance of 0.1m from the EUT. Discharges were applied to the coupling plane, with this plane in sufficient different positions that the four faces of the EUT are completely illuminated.

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### 10.7 Test result

Test Times: 20 times at each point for contact discharge; 20 times at each point for air discharge.						
Operation	Toot Perform		Test Performance		Result	
Mode	Type of discharge	Test Level	Point	Require d	Observati on	(Pass/Fail)
	Contact to EUT	±4kV	4,7,8,9	В	Α	Pass
Mode 1	Contact to Coupling Planes	±4kV	Coupling Planes	В	А	Pass
lviode i	Air	±2kV, ±4kV,±8kV	1,2,3,5,6, 7,10,11,1 2,13,14	В	А	Pass

Report No.: DDT-B22111803-3E01

Test Point:

No.	Description	No.	Description	No.	Description
1	Gap	2	Status lamp	3	Power switch
4	LAN Port	5	USB Port	6	HDMI Port
7	VGA Port	8	Shield cover	9	Screw
10	MIC IN Port	11	HEADPHONE Port	12	eSATA
13	DC Power	14	ALARM Port		

Observation Description:

Data transmission loss rate: 0%

A: Operation as intend, no loss of function during test and after test. Data transmission loss rate≤5%.

Test Times: 10 times at each point for contact discharge; 10 times at each point for air discharge.

Operation			Toot	Performa	nce	Result
Operation Mode	Type of discharge	Test Level	Test Point	Require d	Observati on	(Pass/Fail)
	Contact to EUT	±6kV	4,7,8,9	A*	A*	Pass
Mode 1	Contact to Coupling Planes	±6kV	Coupling Planes	A*	A*	Pass
IVIOGE 1	Air	±2kV, ±4kV,±8kV	1,2,3,5,6, 7,10,11,1 2,13,14	A*	A*	Pass

Test Point:

No.	Description	No.	Description	No.	Description
1	Gap	2	Status lamp	3	Power switch
4	LAN Port	5	USB Port	6	HDMI Port
7	VGA Port	8	Shield cover	9	Screw
10	MIC IN Port	11	HEADPHONE Port	12	eSATA
13	DC Power	14	ALARM Port		

Observation Description:

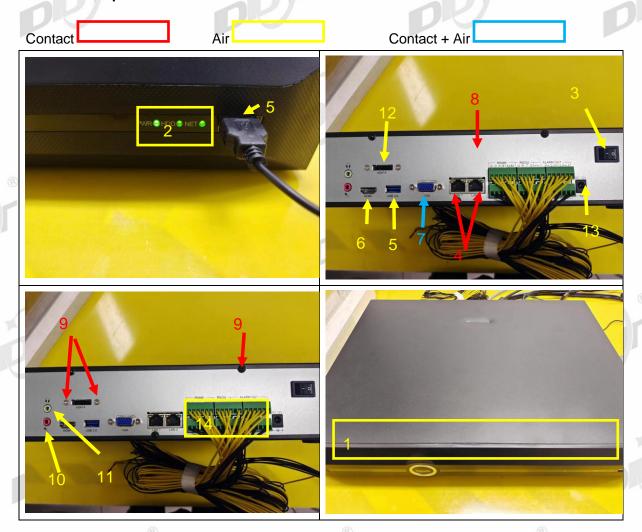
Before the conditioning, the sample function test is normal.

Data transmission loss rate: 0%

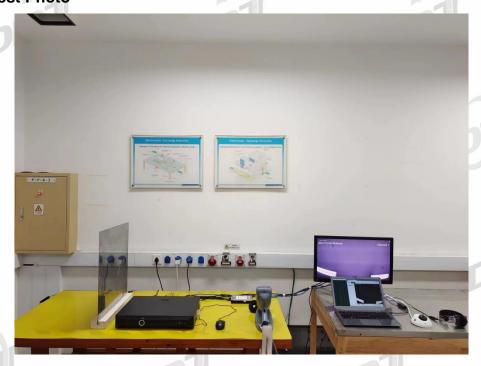
A\*: No damage, failure, or change of condition due to adjustment. Data transmission loss rate≤5%.

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# Photo of ESD point on EUT



# 10.8 Test Photo



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# 11. Continuous Radio Frequency Disturbances

## 11.1 General information

Test date	Dec. 14, 2022 Dec. 21,2022	Test engineer	Make		
Climate condition	Ambient temperature	<b>21.5±1</b> ℃	Relative humidity	38±1%	
Climate condition	Atmospheric pressure	101.1±0.2kPa			
Test place	3m Chamber 1#				

Report No.: DDT-B22111803-3E01

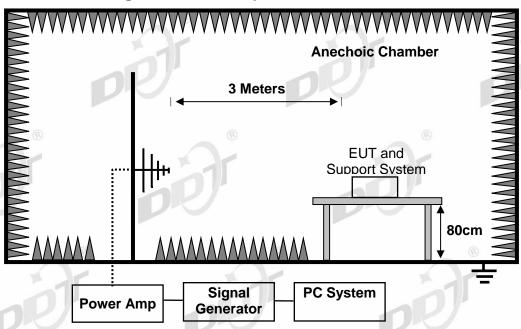
## 11.2 Test equipment

Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
Signal Generator	R&S	SMB100A	104909	Feb. 15, 2022	1 Year
RF Switch for Radiated	SKET	RS_DC06G-AMC-3C	SK20200819 01	N/A	N/A
Power Amplifier	SKET	HAP_01G032G-250W	202104178	Aug. 3, 2022	1 Year
Power Amplifier	SKET	HAP_03G06G-75W	SK20210622 1	Aug. 23, 2022	1 Year
Power Amplifier (Combiner)	SKET	HAP_80M200M/200M 1G-2000/1000W	202102154	Aug. 3, 2022	1 Year
Power meter	R&S	NRP	102424	Feb. 15, 2022	1 Year
Power sensor®	R&S	NRP-Z91	100937	Feb. 15, 2022	1 Year
Power sensor	R&S	NRP-Z91	100938	Feb. 15, 2022	1 Year
Log-periodic antenna	Schwarzbeck	STLP 9149	9149-059	N/A	N/A
Log-periodic antenna	Schwarzbeck	STLP 9128 E special	9128ES-171	N/A	N/A

### 11.3 Test and reference standards

EN 55035:2017/A11:2020 IEC 61000-4-3:2020 EN 50130-4:2011/A1:2014

## 11.4 Block diagram of test setup



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## 11.5 Test levels and performance criterion

EN 55035:2017/A11:2020:

(8)	Performance Criteria	
Frequency (MHz)	80 to 1000	
Field Strength	3V/m rms voltage level of the unmodulated signal	-31
Modulation	AM modulated to a depth of 80% by a sine wave of ⊠1kHz, □400Hz (note 1)	A
Step Size	1% increments	
Dwell time	<5 Sec. ®	

Report No.: DDT-B22111803-3E01

nP	Performance Criteria	
Frequency (MHz)	1800, 2600, 3500, 5000	
Field Strength	3V/m rms voltage level of the unmodulated signal	Δ.
Modulation	AM modulated to a depth of 80% by a sine wave of ⊠1kHz, □400Hz (note 1)	А
Dwell time	<5 Sec.	

Note 1: The 1kHz modulation may be replaced by a different audio modulation frequency more appropriate for a given EUT if, for example, 1kHz is not within the operating audio range of the EUT.

Performance criteria A description for devices with the audio output function: The measured acoustic interference ratio and/or the measured electrical interference ratio during the test shall be -20 dB or better.

For equipment with audio output function:

☐ The acoustic measurement method was selected according to clause G6.4.1 of EN 55035. ☐ The electrical measurement method was selected according to clause G6.4.2 of EN 55035.

Performance criteria A for devices with the telephony function.

Frequency range	Acoustic or	Equivalent direct measurement			
MHz	electrical interference ratio	dB(SPL)	Digital dBm0	Analogue dBm0	
80 to 1000	-0 dB	75	-30	-30	

Note: At the step in the frequency range, the lower limit shall be applied.

The interference ratio (electrical or acoustic) shall meet the limits in column 2; or,

The acoustic level of the demodulated audio shall be less than the limits in column 3; or

The digitally coded level of demodulated audio shall be less than limits in column 4; or,

The analogue level of the demodulated audio shall be less than the limits in column 5.

Performance criteria A description for other devices: During and after the test the EUT shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed below a minimum performance level specified by the manufacturer when the EUT is used as intended.

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EN 50130-4:2011/A1:2014:

	Swept frequency test					
Frequency (MHz)	80 to 2700	(B)				
Field Strength	10V/m rms voltage level of the unmodulated signal	Sar .				
Modulation	AM modulated to a depth of 80% by a sine wave of ⊠1kHz, □400Hz (note 1)	A*				
Step Size	1% increments					
Dwell time	≥3 Sec.					

Report No.: DDT-B22111803-3E01

Performance criteria A\* description: There shall be no damage, malfunction or change of status due to the conditioning. Flickering of an indicator during the conditioning is permissible, providing that there is no residual change in the EUT or any change in outputs, which could be interpreted by associated equipment as a change, and no such flickering of indicators occurs at a field strength of 3 V/m.

For components of CCTV systems, where the status is monitored by observing the TV picture, then deterioration of the picture is allowed at 10 V/m, providing.

- a) there is no permanent damage or change to the EUT (e.g. no corruption of memory or changes toprogrammable settings etc.);
- b) at 3 V/m, any deterioration of the picture is so minor that the system could still be used; and
- c) there is no observable deterioration of the picture at 1 V/m.

### 11.6 Test procedure

The field sensor is placed on the EUT table (0.8 meter above the ground) which is 3 meters away from the transmitting antenna. Through the signal generator, power amplifier and transmitting antenna to produce a uniformity field strength (3V/m or 10V/m measured by field sensor) around the EUT table from frequency range specified and records the signal generator's output level at the same time for whole measured frequency range. Then, put EUT and its simulators on the EUT turn table and keep them 3 meters away from the transmitting antenna which is mounted on an antenna tower and fixes at 1.4 meter height above the ground. Using the recorded signal generator's output level to measure the EUT from frequency range specified and both horizontal & vertical polarization of antenna must be set and measured. Each of the four sides of EUT must be faced this transmitting antenna and measures individually.

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# 11.7 Test result

Field Strength :   ☐3V/m ☐10V/m Steps: ☐1% ☐other: Dwell time: ☐1s ☐other:						
Swept Frequency other:	y Range: ⊠80M⊦	lz1GHz; 🏻	☑1800MHz, 2	600MHz, 35	00MHz, 5000	MHz; 🗌
Modulation : I	None ⊠AM ⊠1	kHz	Hz Modulatio	n depth: 🖂8	30% Oother:	
	EUT Position	Antenna: H	orizontal	Antenna: Ve	ertical	Result
Operation Mode	towards antenna	Required	Observation	Required	Observation	(Pass/Fail)
F-0.	Front	Α	A	Α	Α	Pass
Mode 1	Right ®	Α	Α	A	А	Pass 🕟
iviode i	Rear	Α	A	Α	Α	Pass
	Left	Α	Α	Α	Α	Pass
	only for the device			n.		77
Note 2: this device	ce without the tele	phony funct	ion.			
Observation Description:						
Data transmissio	n loss rate: 0%					
A: Operation as i	ntend, no loss of	function duri	ng test and af	ter test. Data	a transmissioi	n loss
rate≤5%.						

Report No.: DDT-B22111803-3E01

Field Strength : ☐3V/m ☑10V/m Steps: ☑1% ☐other: Dwell time: ☑3s ☐other:							
Swept Frequency Range: ⊠80MHz1GHz; ⊠1GHz-2.7GHz; ⊡other:							
Modulation :   N	None ⊠AM ⊠1	kHz	Hz Modulatio	n depth: ⊠8	0% Other:		
	EUT Position Antenna:		orizontal	Antenna: Vertical		Result	
Operation wode	towards antenna	Required	Observation	Required	Observation	(Pass/Fail)	
	Front	A*	A*	A*	A*	Pass	
Mode 1	Right A* A* A* Pass						
Mode 1 Rear A* A* A* Pass							
	Left	A*	A*	A*	A*	Pass	

Observation Description:

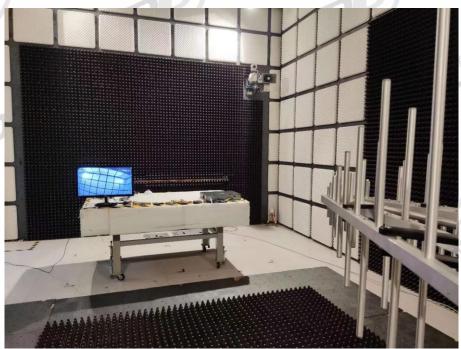
Before the conditioning, the sample function test is normal.

Data transmission loss rate: 0%

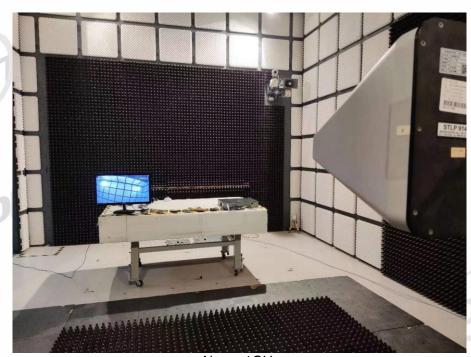
A: No damage, failure, or change of condition due to adjustment. Data transmission loss rate≤5%.

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# 11.8 Test Photo



80MHz-1GHz



Above 1GHz

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# 12. Electrical Fast Transients (EFT)

## 12.1 General information

Test date	© Dec. 14, 2022 Dec. 27,2022	Test engineer	Oliver			
Climate condition	Ambient temperature	<b>19.5±1</b> ℃	Relative humidity	37±1%		
Climate condition	Atmospheric pressure 102.9±0.2kPa					
Test place	Shield Room 3#					

Report No.: DDT-B22111803-3E01

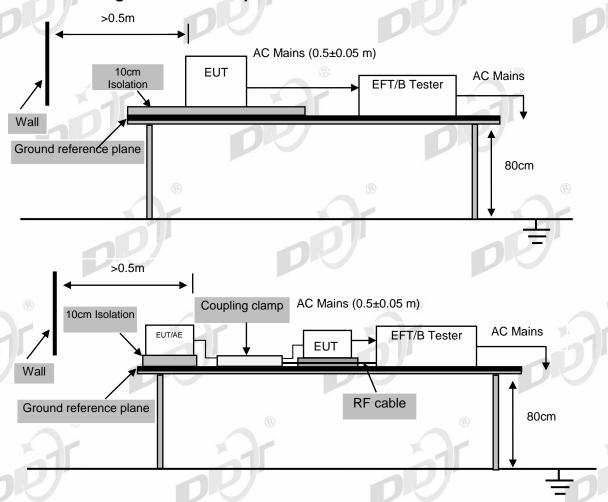
## 12.2 Test equipment

Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
EFT Generator	TESEQ	NSG 3060	1338	Feb. 15, 2022	1 Year
Coupling/Decoup ling Network	TESEQ	CDN3061	210	Feb. 15, 2022	1 Year
Capacitive Coupling Clamp	TESEQ	CDN 8014	29223	Feb. 16, 2022	1 Year

### 12.3 Test and reference standards

EN 55035:2017/A11:2020 IEC 61000-4-4:2012 EN 50130-4:2011/A1:2014

### 12.4 Block diagram of test setup



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### 12.5 Test levels and performance criterion

EN 55035:2017/A11:2020

	Performance Criteria		
Test voltage	±1kV For AC mains Port	±0.5kV for DC input or signal Port	1
Repetition Frequency	5kHz	5kHz	
Burst Duration	15ms	15ms	
Burst Period	300ms 300ms		В
Inject Time(s)	120s	120s	
Inject Method	Direct for AC mains port	Direct for signal port Direct for dc input port	DRY
Inject Line	AC Mains of adapter	DC input of adapter or Capacitive coupling clamp	

Report No.: DDT-B22111803-3E01

Note: This test shall be additionally performed on analogue/digital data ports, and DC network power ports, of radio equipment and associated ancillary equipment, if the cables may be longer than 3 m.

Performance criteria B description: During the test, degradation of performance is allowed. However, no change of operating state or stored data is allowed to persist after the test. After the test, the EUT shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed, after the application of the phenomena below a performance level specified by the manufacturer, when the EUT is used as intended.

#### EN 50130-4:2011/A1:2014

	Performance Criteria		
Test voltage	±2kV for AC mains Port ±1kV for other supplyt or signal Port <sup>b</sup>		®
Repetition Frequency	100kHz 100kHz		ar a
Burst Duration	0.75ms	0.75ms	יו כ
Burst Period	300ms	300ms	A*
Inject Time(min)	1min	1min	
Inject Method	Direct for AC mains port	Direct for signal port Direct for dc input port	®
Inject Line	AC Mains of adapter	DC input of adapter or Capacitive coupling clamp	51

#### Note:

a. Applied by a CDN. DC ports, which are not intended to be connected to a DC distribution network, e.g. outputs for Sounders, are treated as signal ports.

b. Applied by the capacitive clamp injection method, no test is required where the manufacturer's specification indicates that it is not permitted to connect cables > 3 m long.

Performance criteria A\* description: There shall be no damage, malfunction or change of status due to the conditioning. Flickering of an indicator during the application of the bursts is permissible, providing that there is no residual change in the EUT or any change in outputs, which could be interpreted by associated equipment as a change.

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### 12.6 Test Procedure

The EUT and its simulators were placed on the ground reference plane and were insulated from it by a wood support  $0.1m \pm 0.01m$  thick. The ground reference plane was  $1m^*1m$  metallic sheet with 0.65mm minimum thickness. This reference ground plane was project beyond the EUT by at least 0.1m on all sides and the minimum distance between EUT and all other conductive structure, except the ground plane was more than 0.5m. All cables to the EUT was placed on the wood support, cables not subject to EFT/B was routed as far as possible from the cable under test to minimize the coupling between the cables.

Report No.: DDT-B22111803-3E01

For DC input and AC power ports:

The EUT was connected to the power mains by using a coupling device that couples the EFT interference signal to AC power lines. Both positive transients and negative transients of test. For signal ports:

The capacitive coupling clamp was connected to the power by using a coupling device that couples the EFT interference signal to capacitive coupling clamp. Both positive transients and negative transients of test voltage were applied during compliance test.

### 12.7 Test result

Port AC Mains	Port ⊠ AC Mains ☐DC Supply ⊠Signal			Burst Period:   300ms □Other:			
Coupling: Direct	ct	ive Clamp	Test Time:   120S □Other:				
Repetition Freque	ency: 🛛 5KHz	z  ☐Other:	Burst Dur	ations: 🖂15ms	□Other:		
			Performa	nce		Result	
Operation Mode	Line/port	Test Voltage	Required	Observation (+)	Observation (-)	(Pass/Fail)	
	L	±1kV	В	A	A	Pass	
	N	±1kV	В	A	A	Pass	
	L-N	±1kV	В	Α	A	Pass	
	PE	±1kV	В	Α	A	Pass	
Mode 1	L-PE	±1kV	В	Α	Α	Pass	
	N-PE	±1kV	В	Α	Α	Pass	
L-N-PE		±1kV	B ®	A	A	Pass	
	LAN1	± 500V	В	Α	A	Pass	
	LAN2	± 500V	В	A	A	Pass	

Observation Description:

Data transmission loss rate: 0%

A: Operation as intend, no loss of function during test and after test. Data transmission loss rate≤5%.

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Port X AC Mains	s □DC Supp	ly ⊠Signal	Ruret Par	iod: 🛛 300ms	Other:	
Coupling: Direct			Test Time: 1 1min Other:			
Repetition Freque				ations: 15ms		
. topoution i roqui	 		Performa		<u> </u>	Result
Operation Mode	Line/port	Test Voltage		Observation	Observation (-)	(Pass/Fail)
		±2kV	A*	À*	À*	Pass
	N	±2kV	A*	A*	A*	Pass
	L-N	±2kV	A*	A*	A*	Pass
	PE	±2kV	A*	A*	A*	Pass
Mode 1	L-PE	±2kV	A*	A*	A*	Pass
	N-PE	±2kV	A*	A* (a)	A*	Pass 🧑
	L-N-PE	±2kV	A*	A*	A*	Pass
	LAN1	±1kV	A*	A*	A*	Pass
	LAN2	±1kV	A*	A*	A*	Pass

Report No.: DDT-B22111803-3E01

Observation Description:

Before the conditioning, the sample function test is normal.

Data transmission loss rate: 0%

A\*: No damage, failure, or change of condition due to adjustment. Data transmission loss rate≤5%.

## 12.8 Test Photo



AC Port

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LAN Port

# 13. Surges

## 13.1 General information

Test date	© Dec. 14, 2022 Dec. 27,2022	Test engineer Oliver				
Climate condition	Ambient temperature	19.5±1℃	Relative humidity 37±1%			
Climate condition	Atmospheric pressure 102.9±0.2kPa					
Test place	Shield Room 3#					

Report No.: DDT-B22111803-3E01

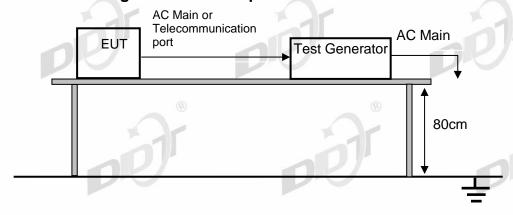
## 13.2 Test equipment

Equipment	Manufacturer	Model No.	Serial No.	1 201 ( 2)	Cal. Interval
Multifunctional Generator	EM Test	UCS 500N7.1	P1303110687	May. 09, 2022	1 Year
Coupling / Decoupling Network	EM Test	CNI 508N1	V1250114301	Mar. 29, 2022	1 Year
3-Phase Coupling Decoupling Network	EM Test	CNI 503B7	V1250114298	Mar. 29, 2022	1 Year
Surge Protection Network	EM Test	SPN 508N1	V1250114303	Mar. 29, 2022	1 Year
Coupling Network	EM Test	CN 508N1	V1250114302	Mar. 29,2022	1 Year

# 13.3 Test and reference standards

EN 55035:2017/A11:2020 IEC 61000-4-5:2014+AMD1:2017 EN 50130-4:2011/A1:2014

# 13.4 Block diagram of test setup



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### 13.5 Test levels and performance criterion

EN 55035:2017/A11:2020

EN 55035:2017/A11:2	2020						
Test level for AC ma	ins ports	Performance Criterion					
Line to Line	Line to Line 1kV 1.2/50(8/20) µs						
Line to Ground	2kV 1.2/50(8/20) μs	В					
Analogue/digital data	a port, Port type: unshielded symmetrical	Performance Criterion					
Line to Ground	1 kV and 4kV 10/700(5/320) µs (used with the primary protection)	C ®					
Line to Ground	1 kV 10/700(5/320) μs (used without the primary protection)	C					
Note: Applicable only lengths greater than	y to ports which, according to the manufacturer's speam.	ecification, the cable					
Analogue/digital data	a port, Port type: coaxial or shielded	Performance Criterion					
Shield to ground	0.5 kV 1.2/50(8/20) μs	В					
Note: Applicable only lengths greater than	y to ports which, according to the manufacturer's spe 3m.	ecification, the cable					
DC network power p	DC network power port						
Line to reference ground	0.5 kV 1.2/50(8/20) μs	В					
The state of the s	y to ports which, according to the manufacturer's sport than 3m; 2. May connect directly to outdoor cables						

Report No.: DDT-B22111803-3E01

Performance criteria B description: During the test, degradation of performance is allowed. However, no change of operating state or stored data is allowed to persist after the test. After the test, the EUT shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed, after the application of the phenomena below a performance level specified by the manufacturer, when the EUT is used as intended.

### EN 50130-4:2011/A1:2014

0.5 kV & 1 kV	Performance Criterion
0,5 kV; 1 kV & 2 kV	A.t.
	A*
0,5 kV & 1 kV	(R)
+ & -	Par
20 <sup>e</sup>	
5	
	0,5 kV & 1 kV + & -

a:The test voltages specified are the open-circuit voltages. The test voltages for the lower severity levels are included because all the lower severity levels also have to be satisfied. b:Via a 10  $\Omega$  series resistor.

c:No test is required where the manufacturer's specification indicates that it is not permitted to connect cables > 30 m long.

d:Via a 40  $\Omega$  series resistor.

e:5 at each zero-crossing point and at the maximum and minimum points on the mains voltage wave.

Performance criteria A\* description: There shall be no damage, malfunction or change of status due to the conditioning. Flickering of an indicator during the application of the surges is

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permissible, providing that there is no residual change in the EUT or any change in outputs, which could be interpreted by associated equipment as a change.

Report No.: DDT-B22111803-3E01

#### 13.6 Test Procedure

For line-to-neutral coupling mode, provide a 0.5 kV/1 kV 1.2/50 us voltage surge (at open-circuit condition) and 8/20 us current surge to EUT selected points.

For line-to-ground coupling mode, provide a 0.5 kV/1 kV/2 kV 1.2/50 us voltage surge (at open-circuit condition) and 8/20 us current surge to EUT selected points.

The number of pulses applied in EN 55035:2017/A11:2020 shall be five positive and negative pulses at 90° and 270° phase.

The number of pulses applied in EN 50130-4:2011/A1:2014 shall be 5 at each zero-crossing point and at the maximum and minimum points on the mains voltage wave.

Maximum 1/min repetition rate are applied during test. Different phase angles are done individually.

For telecommunication surge test, each line of internet port to ground coupling mode, provide a 1.0kV 10/700us voltage surge (at open-circuit condition) and 5/320us current surge to EUT selected points.

At least 5 positive and 5 negative (polarity) tests with a maximum 1/min repetition rate are applied during test.

Record the EUT operating situation during compliance test and decide the EUT immunity criterion for above each test.

#### 13.7 Test result

Line: 🛛 AC I	Mains 📵	DC Supply	y 🔯	Telecor	nmunicatio	on port	Si	gnal port	8		
Wave Type: 42Ω⊡160Ω	⊠ 1.2/50ເ	us-8/20us	⊠ 10	/700 us	-5/320us I	nterna	l impe	dance: 🖂	2Ω⊠12	2Ω[]2	25Ω⊠
Pulse times: 90°, 270°	5 times at	each pola	rity I	Pulse In	iterval: 60	S Volta	ige Ph	ase: 🗌 0°	, 90°, 1	80°, 2	270°⊠
Operation	lino/	0.5kV			1kV			2kV			Result
Operation Mode	Line/ Port	Required	Obse +	rvation -	Required	Obser + ®	vation -	Required	Observ +	ation	Pass/Fail
	L-N	В	Α	Α	В	Α	Α	N/A	N/A	N/A	Pass
	L-PE	В	Α	Α	В	Α	Α	В	A	Α	Pass
Mode 1	N-PE	В	Α	Α	В	Α	Α	В	Α	Α	Pass
	LAN1	С	Α	Α	С	Α	Α	N/A	N/A	N/A	Pass
	LAN2	С	A ®	Α	С	Α	A ®	N/A	N/A	N/A	Pass ®

Observation Description:

Data transmission loss rate: 0%

A: Operation as intend, no loss of function during test and after test. Data transmission loss rate≤5%.

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Line: 🔀 AC I	Mains 🗌	DC Supply	y 🔯	Telecor	nmunicatio	n port	Si	gnal port			
Wave Type: 42Ω⊡160Ω	⊠ 1.2/50ເ	us-8/20us	⊠ 10/	/700 us	-5/320us I	nterna	limpe	dance: 🖂	2Ω⊠12	2Ω∏2	25Ω⊠
Pulse times: 90°, 270°	5 times at	each pola	rity F	Pulse In	iterval: 609	S Volta	ige Ph	ase: 🗵 0°	', 90°, 1	80°, 2	270°
Operation	Line/	0.5kV			1kV			2kV			Result
Operation Mode		Required	Obse +	rvation -	Required	Obser +	vation -	Required	Observ +	/ation -	Pass/Fail
	L-N	A*	A*	A*	A*	A*	A*	N/A	N/A	N/A	Pass
	L-PE	A*	A*	A*	A*	A*	A*	A*	A*	A*	Pass
Mode 1	N-PE	A* ®	A*	A*	A*	A* ®	A*	A*	A*	A*	Pass
	LAN1	A*	A*	A*	A*	A*	A*	N/A	N/A	N/A	Pass
	LAN2	A*	Α*	A*	A*	A*	A*	N/A	N/A	N/A	Pass

Report No.: DDT-B22111803-3E01

Observation Description:
Before the conditioning, the sample function test is normal.
Data transmission loss rate: 0%

A\*:No damage, failure, or change of condition due to adjustment. Data transmission loss rate≤5%

# **Test Photo**



AC Port

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LAN Port

# 14. Continuous Conducted Disturbances

## 14.1 General information

Test date	Dec. 14, 2022 Dec. 27,2022	Test engineer	Oliver					
Climata asuditisu	Ambient temperature	19.5±1℃	Relative humidity 37±1%					
Climate condition	Atmospheric pressure 102.9±0.2kPa							
Test place		Shield Room 3	#					

Report No.: DDT-B22111803-3E01

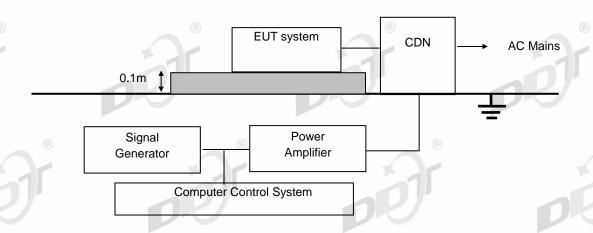
## 14.2 Test Equipment

Equipment	Manufacturer	Model No.	Serial No.	II ast Cal	Cal. Interval
Signal Generator	R&S	SMB100A	103231	Feb. 15, 2022	1 Year
CDN	TESEQ	CDN M016	28987	Feb. 16, 2022	1 Year
RF Power Amplifiers	AR ®	75A250A	0332892 ®	Feb. 16, 2022	1 Year
Directional Coupler	AR	DC2600M2	0333399	Feb. 16, 2022	1 Year
Power Meter	R&S	NRVS	101785	Mar. 29, 2022	1 Year
Coaxial voltage measurement probe	R&S	URV5-Z4	100215	Mar. 29, 2022	1 Year
EM Injection Clamp	FCC	F-203I-23MM	100331	Feb. 16, 2022	1 Year
COUPLING / DECOUPLING NETWORK	TESEQ	CDN T800	39134	Feb. 16, 2022	1 Year
Test Software	R&S	EMC 32	Ver 10.28.0	N/A	N/A

### 14.3 Test and reference standards

EN 55035:2017/A11:2020 IEC 61000-4-6:2013 EN 50130-4:2011/A1:2014

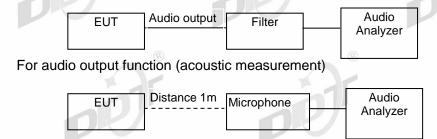
## 14.4 Block diagram of test setup



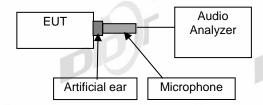
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For audio output function (electrical measurement, direct connection to EUT)

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For audio output function (on-ear acoustic measurement)



## 14.5 Test levels and performance criterion

EN 55035:2017/A11:2020

Test Level		Performance Criteria
(8)	0.15MHz to 10MHz, 3V rms voltage level of the unmodulated signal	8
Frequency and Field Strength	10MHz to 30MHz, 3V to 1V rms voltage level of the unmodulated signal	
	30MHz to 80MHz, 1V rms voltage level of the unmodulated signal	A
Modulation	AM modulated to a depth of 80% by a sine wave of ⊠1kHz, □400Hz (note¹1)	(8)
Step Size	1% increments	
Dwell time	1 Sec.	

Note 1: The 1kHz modulation may be replaced by a different audio modulation frequency more appropriate for a given EUT if, for example, 1kHz is not within the operating audio range of the EUT.

Performance criteria A description for devices with the audio output function: The measured acoustic interference ratio and/or the measured electrical interference ratio during the test shall be -20 dB or better.

The acoustic measurement method was selected according to clause G6.4.1 of EN 55035.

The electrical measurement method was selected according to clause G6.4.2 of EN 55035.

Performance criteria A for devices with the telephony function.

Frequency range	Acoustic or electrical	Equivalent direct measurement			
MHz	interference ratio	dB(SPL)	Digital dBm0	Analogue dBm0	
0.15 to 30	-20 dB	55	-50	-50	
30 to 80	-10 dB	65	-40	-40	

Note: At the step in the frequency range, the lower limit shall be applied.

The interference ratio (electrical or acoustic) shall meet the limits in column 2; or,

The acoustic level of the demodulated audio shall be less than the limits in column 3; or

The digitally coded level of demodulated audio shall be less than limits in column 4; or,

The analogue level of the demodulated audio shall be less than the limits in column 5.

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Performance criteria A description for other devices: During and after the test the EUT shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed below a minimum performance level specified by the manufacturer when the EUT is used as intended.

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EN 50130-4:2011/A1:2014

Test Level		Performance
1621 FEAGI		Criteria
Frequency and Field	0.15MHz to 100MHz, 10V rms voltage level of	
Strength	the unmodulated signal	
Modulation	AM modulated to a depth of 80% by a sine wave	1
Modulation	of ⊠1kHz, □400Hz (note 1)	A*
Step Size	1% increments	×-Ar
Dwell time	≥3 Sec.	

Performance criteria  $A^*$  description: There shall be no damage, malfunction or change of status due to the conditioning. Flickering of an indicator during the conditioning is permissible, providing that there is no residual change in the EUT or any change in outputs, which could be interpreted by associated equipment as a change, and no such flickering of indicators occurs at  $U_0 = 3V$ .

For components of CCTV systems, where the status is monitored by observing the TV picture, then deterioration of the picture is allowed at  $U_0 = 10V$ , providing

- a) there is no permanent damage or change to the EUT (e.g. no corruption of memory or changes toprogrammable settings, etc.),
- b) at  $U_0 = 3V$ , any deterioration of the picture is so minor that the system could still be used, and
- c) there is no observable deterioration of the picture at  $U_0 = V$ .

### 14.6 Test procedure

The EUT are placed on an insulating support 0.1m high above a ground reference plane. CDN (coupling and decoupling device) is placed on the ground plane about 0.3m from EUT. Cables between CDN and EUT are as short as possible, and their height above the ground reference plane shall be between 30 and 50 mm (where possible).

The disturbance signal described below is injected to EUT through CDN.

The EUT operates within its operational mode(s) under intended climatic conditions after power

The frequency range is swept from 0.150MHz to  $\boxtimes 80$ MHz/ $\boxtimes 100$ MHz, the interference signal level according to clause 10.5, and with the disturbance signal 80% amplitude modulated with a  $\boxtimes 1$ kHz /  $\square 400$ Hz sine wave.

The rate of sweep shall not exceed 1.5\*10-3decades/s. Where the frequency is swept incrementally; the step size shall not exceed 1% of the start and thereafter 1% of the preceding frequency value.

Recording the EUT operating situation during compliance testing and decide the EUT immunity criterion.

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## **Test result**

Operation	Frequency	Injected	Strength(e.m.f)	Poquirod	Observation	Result
mode	Range	Position	(unmodulated)	rtequired	Obscivation	(Pass/Fai
	0.15MHz-10MHz	AC Port	3V	Α	A	Pass
	10MHz-30MHz	AC Port	3V-1V	Α	A	Pass
	30MHz-80MHz	AC Port	1V ®	А	A	Pass ®
	0.15MHz-10MHz	LAN1 Port	3V	А	А	Pass
Mode 1	10MHz-30MHz	LAN1 Port	3V-1V	А	A	Pass
	30MHz-80MHz	LAN1 Port	1V	А	А	Pass
8	0.15MHz-10MHz	LAN2 Port	3V	A ®	А	Pass
	10MHz-30MHz	LAN2 Port	3V-1V	A	А	Pass
	30MHz-80MHz	LAN2 Port	1V	Α	Α	Pass

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Note 2: this device without the telephony function.

Observation Description:

Data transmission loss rate: 0%

A: Operation as intend, no loss of function during test and after test. Data transmission loss rate≤5%.

Modulation Signal: ⊠1kHz □400Hz 80% AM □Other: Steps: ⊠1% □other: Dwell time: ⊠3s □other:							
Operation	Frequency	Injected	Strength(e.m.f) (unmodulated)	Required	Observation	Result	
mode	Range	Position 🦈	(unmodulated)	rtoquirou	Obscivation	(Pass/Fail)	
00	0.15MHz- 100MHz	AC Port	9 11			Pass	
Mode 1	0.15MHz- 100MHz	LAN1 Port	3V	A*	A*	Pass	
	0.15MHz- 100MHz	LAN2 Port	3V ®	A*	A*	Pass	

Observation Description:

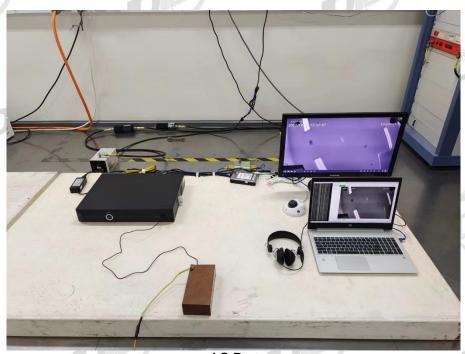
Before the conditioning, the sample function test is normal.

Data transmission loss rate: 0%

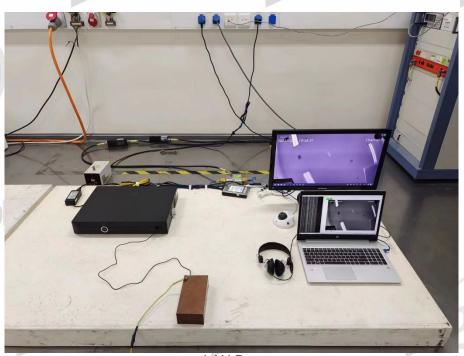
A\*:No damage, failure, or change of condition due to adjustment. Data transmission loss

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# 14.8 Test Photo



AC Port



LAN Port

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# 15. Power-Frequency Magnetic Fields

## 15.1 General information

Test date	® Dec. 13, 2022	Test engineer	Oliver				
Olimenta ann dition	Ambient temperature	19.5±1℃	Relative humidity 37±1%				
Climate condition	Atmospheric pressure 102.9±0.2kPa						
Test place		Shield Room 3#					

Report No.: DDT-B22111803-3E01

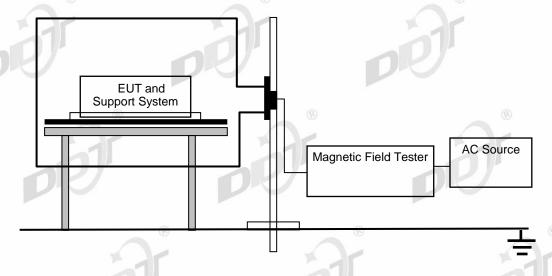
# 15.2 Test equipment

Equipment	Manufacturer	Model No.	Serial No.	II act Cal	Cal. Interval
Magnetic Field Coil	TESEQ	INA 702	199	Feb. 16, 2022	1 Year
Magnetic Field Option	TESEQ	MFO 6502	123	Feb. 16, 2022	1 Year
Multifunction Generator Systems	TESEQ	NSG 3060	1338	Feb. 15, 2022	1 Year
Coupling/Deco upling Networks	TESEQ	CDN 3061	210	Feb. 15, 2022	1 Year

# 15.3 Test and reference standards

EN 55035:2017/A11:2020 IEC 61000-4-8:2009

# 15.4 Block diagram of test setup



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## 15.5 Test levels and performance criterion

Level	Magnetic F (A/m)	Field Strength Performance Criterion	
1	® 1	A	3

Report No.: DDT-B22111803-3E01

Performance criteria A description: During and after the test the EUT shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed below a minimum performance level specified by the manufacturer when the EUT is used as intended.

### 15.6 Test procedure

The EUT shall be subjected to the test magnetic field by using the induction coil of standard dimensions (1m\*1m) and shown in Section 14.4 Then induction coil shall then be rotated by 90°in order to expose the EUT to the test field with different orientations.

### 15.7 Test result

Operation Mode	Test Level	Testing	Coil	Poquirod	Observation	Result
		Duration	Orientation	Nequireu	Observation	(Pass/Fail)
Mode 1	1A/m	5min/coil	Χ	Α	Α	Pass
		5min/coil	Υ	Α	Α	Pass
		5min/coil	Z	Α	A	Pass

Observation Description:

Data transmission loss rate: 0%

A: Operation as intend, no loss of function during test and after test. Data transmission loss rate≤5%.

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# 15.8 Test Photo



# 16. Voltage Dips and Interruptions

## 16.1 General information

Test date	© Dec. 14, 2022 Dec. 27,2022	Test engineer	Oliver				
Climate condition	Ambient temperature	e 19.5±1℃ Relative humid		37±1%			
Climate condition	Atmospheric pressure 102.9±0.2kPa						
Test place		Shield Room 3#					

Report No.: DDT-B22111803-3E01

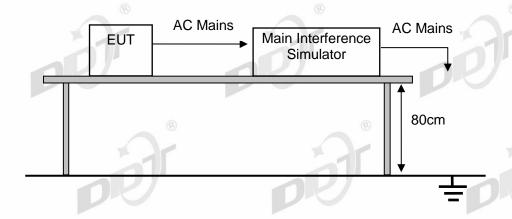
## 16.2 Test equipment

Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
Motorized single phase variac	TESEQ	VAR 3005- D16	094	Feb. 15, 2022	1 Year
Multifunction Generator Systems		NSG 3060	1338	Feb. 15, 2022	1 Year
Coupling/Decoup ling Networks	TESEQ	CDN 3061	210	Feb. 15, 2022	1 Year

### 16.3 Test and reference standards

EN 55035:2017/A11:2020 IEC 61000-4-11:2020 EN 50130-4:2011/A1:2014

## 16.4 Block diagram of test setup



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### 16.5 Test levels and performance criterion

#### EN 55035:2017/A11:2020

Test Level %UT	Duration (in period)	Performance Criterion
<5	0.5	В
70	25 for 50Hz/30 for 60Hz	С
<5	250 for 50Hz/300 for 60Hz	С

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Performance criteria B description: During the test, degradation of performance is allowed. However, no change of operating state or stored data is allowed to persist after the test. After the test, the EUT shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed, after the application of the phenomena below a performance level specified by the manufacturer, when the EUT is used as intended. Performance criteria C description: During and after testing, a temporary loss of function is allowed, provided the function is self recoverable, or can be restored by the operation of the controls or cycling of the power to the EUT by the user in accordance with the manufacturer's instructions. Functions, and/or information stored in non-volatile memory, or protected by a battery backup, shall not be lost.

#### EN 50130-4:2011/A1:2014

Test Level	%UT	Duration (in period)		Perf	ormance Crite	rion
80		250 for 50h	Ηz		A*	
70		25 for 50H	z		Α*	
40		10 for 50H	z		A*	
0		250 for 50h	Ηz		B*	

Performance criteria A\* description: There shall be no damage, malfunction or change of status due to the conditioning. Flickering of an indicator during the conditioning is permissible, providing that there is no residual change in the EUT or any change in outputs, which could be interpreted by associated equipment as a change.

Performance criteria B\* description: Signalling a mains fault during the 100 % voltage reduction test is permitted.

### 16.6 Test procedure

The EUT and test generator were setup as shown. The interruptions are introduced at selected phase angles with specified duration. Record any degradation of performance.

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### 16.7 Test result

Power Supply: AC 100V/60Hz								
Operation	Voltage Dips &	Duration F	Phase			Result		
Mode	Short Interruptions %Ur	(in period)	Angle	Required	Observation	(Pass/Fail)		
Mode 1	0	0.5P	0°,180°	В	A	Pass		
	70	30P	0°,180°	С	A	Pass		
	0	300P	0°,180°	С	С	Pass		

Report No.: DDT-B22111803-3E01

Observation Description:

Voltage Dips' data transmission loss rate: 0%

Short Interruptions' data transmission loss rate: 10%

A: Operation as intend, no loss of function during test and after test. Data transmission loss rate≤5%.

C: EUT lost communication, and recovers its normal performance, with operator intervention.

Power Supply: AC 240V/50Hz								
Operation	Voltage Dips &	oltage Dips & Duration	Phase			Result		
Mode	Short Interruptions %Ur	(in period)	Angle	Required	Observation	(Pass/Fail)		
Mode 1	0	0.5P	0°,180°	В	Α	Pass		
	70	25P	0°,180°	С	Α	Pass		
	0	250P	0°,180°	С	С	Pass		

Observation Description:

Voltage Dips' data transmission loss rate: 0%

Short Interruptions' data transmission loss rate: 10%

A: Operation as intend, no loss of function during test and after test. Data transmission loss rate≤5%.

C: EUT lost communication, and recovers its normal performance, with operator intervention.

Power Supply: AC 100V/50Hz								
Operation Mode	Voltage Dips & Short Interruptions %Ur	Duration (in period)	Phase Angle	Required	Observation	Result (Pass/Fail)		
	80	250P	0°,180°	A*	A*	Pass		
Mode 1	70	25P	0°,180°	A*	A*	Pass		
iviode i	40	10P	0°,180°	A*	A*	Pass		
	0	250P	0°,180°	B*	B*	Pass		

Observation Description:

Before the conditioning, the sample function test is normal.

Voltage Dips' data transmission loss rate: 0%

Short Interruptions' data transmission loss rate: 10%

A\*:No damage, failure, or change of condition due to adjustment. Data transmission loss rate≤5%.

B\*: Transient power failure and data transmission loss occurred during 100% voltage drop test.

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Power Supply: AC 240V/50Hz									
Operation Mode	Voltage Dips &	Duration	Phase			Result			
	Short Interruptions %Ur	(in period)	Angle	Required Observation		(Pass/Fail)			
	80	250P	0°,180°	A*	A*	Pass			
Mode 1	70	25P	0°,180°	A*	A*	Pass			
Mode 1	40	10P	0°,180°	A*	A*	Pass			
	0	250P	0°,180°	B*	B*	Pass			

Report No.: DDT-B22111803-3E01

Observation Description:

Before the conditioning, the sample function test is normal. Voltage Dips' data transmission loss rate: 0%

Short Interruptions' data transmission loss rate: 10%

A\*:No damage, failure, or change of condition due to adjustment. Data transmission loss rate≤5%. B\*: Transient power failure and data transmission loss occurred during 100% voltage drop test.

# 16.8 Test Photo



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# Annex A Photos of the EUT

**External Photographs** 

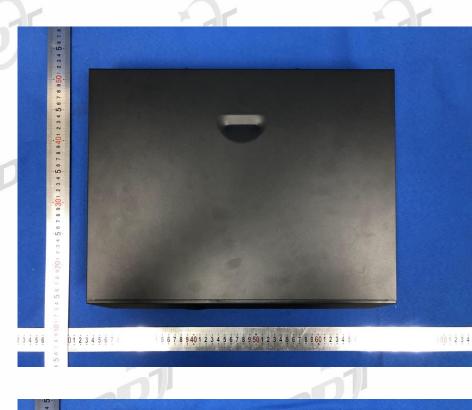


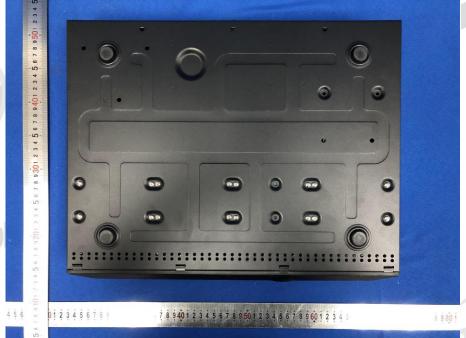


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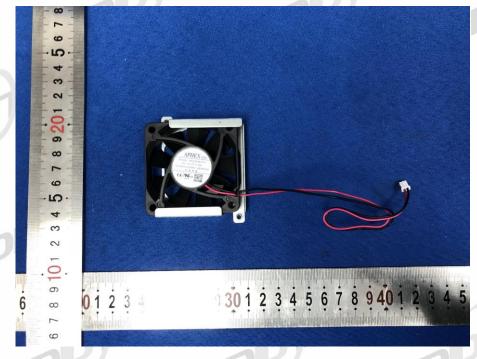
# **Internal Photographs**



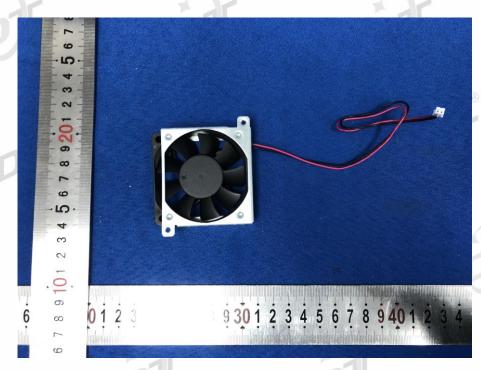


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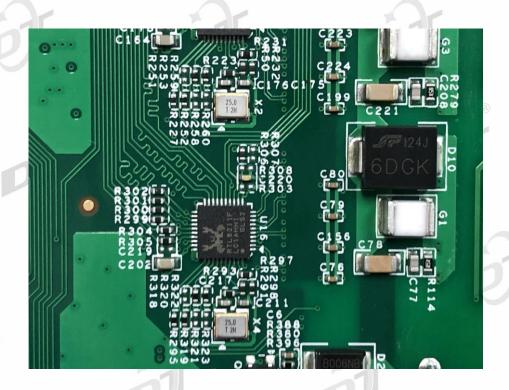
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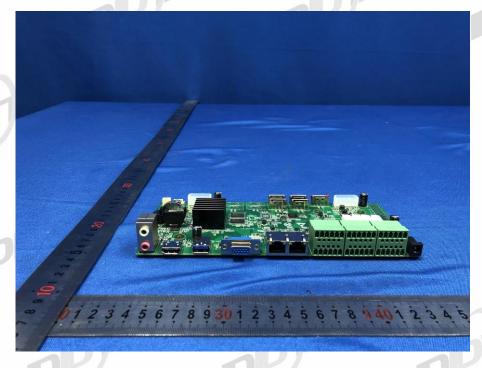
# PCB



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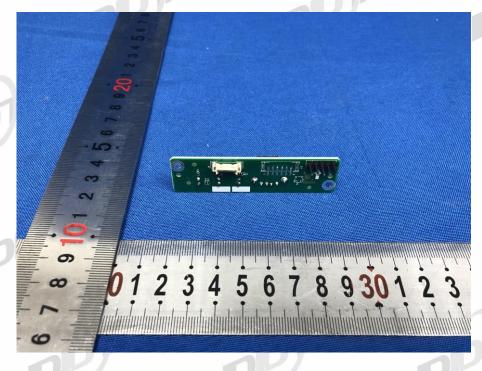
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# **Statement**

Report No.: DDT-B22111803-3E01

- The report is invalid without the inspection and testing special seal of the company.
- 2. This report is invalid if altered.
- 3. This report is responsible for the conformance testing of sample(s) received.
- 4. This report shall not be reproduced, without the written approval of test laboratory. The copy of the report not stamped again with the inspection and testing special seal is invalid.
- 5. Item with "☆" was subcontracted to other laboratories.
- 6. The report without CMA mark has no effect on social proof.
- 7. Any objections must be raised to our company within 15 days on receiving the report, overdue will not be accepted.
- 8. The sample(s) must be collected within three months, overdue will be dealt with by our company.
- 9. The report is invalid without the signature of editor, reviewer, approver.

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**END OF REPORT** 

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